



SMF10N50-Z

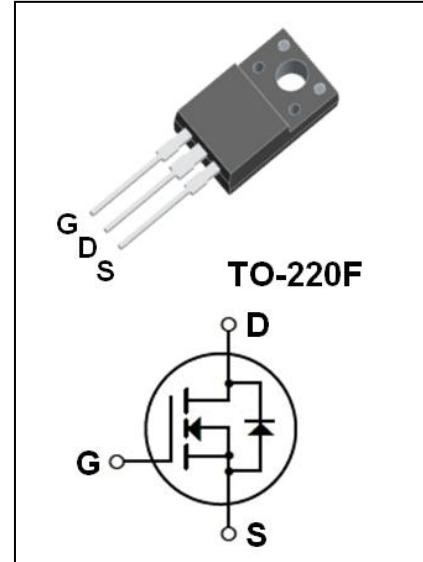
500V N-Channel MOSFET

● Features:

- 10.0A, 500V, $R_{DS(on)(Typ)} = 0.63\Omega$ @ $V_{GS} = 10V$
- Low Gate Charge
- Low C_{rss}
- 100% Avalanche Tested
- Fast Switching
- Improved dv/dt Capability

● Application:

- High Frequency Switching Mode Power Supply
- Active Power Factor Correction



Absolute Maximum Ratings ($T_c = 25^\circ C$ unless otherwise noted)

Symbol	Parameter		Value	Unit
V_{DSS}	Drain-Source Voltage		500	V
I_D	Drain Current	- Continuous($T_c = 25^\circ C$)	10.0*	A
		- Continuous($T_c = 100^\circ C$)	6.3*	A
I_{DM}	Drain Current	-Pulsed (Note1)	40*	A
V_{GSS}	Gate-Source Voltage		± 30	V
E_{AS}	Single Pulsed Avalanche Energy (Limit Reference Value)		378	mJ
I_{AR}	Avalanche Current (Note1)		9.0	A
dv/dt	Peak Diode Recovery dv/dt (Note3)		4.5	V/ns
P_D	Power Dissipation($T_c = 25^\circ C$) -Derate above $25^\circ C$		46	W
		0.37	W/ $^\circ C$	
T_j	Operating Junction Temperature		150	$^\circ C$
T_{stg}	Storage Temperature Range		-55 to +150	$^\circ C$

* Drain Current Limited by Maximum Junction Temperature.

Thermal Characteristics

Symbol	Parameter	Max	Unit
$R_{\theta JC}$	Thermal Resistance, Junction to Case	2.72	$^\circ C / W$
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	62.5	$^\circ C / W$



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Electrical Characteristics($T_c=25^\circ\text{C}$ unless otherwise noted)

Symbol	Parameter	Test Conditons	Min	Typ	Max	Unit
Off Characteristics						
BV_{DSS}	Drain-source Breakdown Voltage	$V_{\text{GS}}=0\text{V}, I_{\text{D}}=250\mu\text{A}$	500	--	--	V
I_{DSS}	Zero Gate Voltage Drain Current	$V_{\text{DS}}=500\text{V}, V_{\text{GS}}=0\text{V}$	--	--	1	μA
		$V_{\text{DS}}=400\text{V}, T_c=125^\circ\text{C}$	--	--	10	μA
I_{GSSF}	Gate-Body Leakage Current,Forward	$V_{\text{GS}}=+30\text{V}, V_{\text{DS}}=0\text{V}$	--	--	100	nA
I_{GSSR}	Gate-Body Leakage Current,Reverse	$V_{\text{GS}}=-30\text{V}, V_{\text{DS}}=0\text{V}$	--	--	-100	nA
On Characteristics						
$V_{\text{GS(th)}}$	Gate Threshold Voltage	$V_{\text{DS}}=V_{\text{GS}}, I_{\text{D}}=250\mu\text{A}$	2.0	--	4.0	V
$R_{\text{DS(on)}}$	Static Drain-Source On-Resistance	$V_{\text{GS}}=10\text{ V}, I_{\text{D}}=5.0\text{A}$	--	0.63	0.75	Ω
g_{FS}	Forward Transconductance	$V_{\text{DS}}=20\text{ V}, I_{\text{D}}=5.0\text{A}$ (Note4)	--	9.5	--	S
Dynamic Characteristics						
C_{iss}	Input Capacitance	$V_{\text{DS}}=25\text{V}, V_{\text{GS}}=0\text{V}, f=1.0\text{MHz}$	--	1370	--	pF
C_{oss}	Output Capacitance		--	118	--	pF
C_{rss}	Reverse Transfer Capacitance		--	6.5	--	pF
Switching Characteristics						
$t_{\text{d(on)}}$	Turn-On Delay Time	$V_{\text{DD}} = 250\text{ V}, I_{\text{D}} = 10.0\text{A}, R_{\text{G}} = 25 \Omega$ (Note4,5)	--	18	--	ns
t_r	Turn-On Rise Time		--	24	--	ns
$t_{\text{d(off)}}$	Turn-Off Delay Time		--	42	--	ns
t_f	Turn-Off Fall Time		--	14	--	ns
Q_g	Total Gate Charge	$V_{\text{DS}} = 400\text{ V}, I_{\text{D}} = 10.0\text{A}, V_{\text{GS}} = 10\text{ V}$ (Note4,5)	--	30.2	--	nC
Q_{gs}	Gate-Source Charge		--	8.6	--	nC
Q_{gd}	Gate-Drain Charge		--	9.8	--	nC
Drain-Source Diode Characteristics and Maximum Ratings						
I_s	Maximum Continuous Drain-Source Diode Forward Current	--	--	10	A	
I_{SM}	Maximum Pulsed Drain-Source Diode Forward Current	--	--	40	A	
V_{SD}	Drain-Source Diode Forward Voltage	$V_{\text{GS}} = 0\text{V}, I_{\text{S}} = 10.0\text{ A}$	--	--	1.4	V
t_{rr}	Reverse Recovery Time	$V_{\text{GS}} = 0\text{V}, I_{\text{S}} = 10.0\text{ A}, dI_{\text{F}}/dt = 100\text{A}/\mu\text{s}$ (Note4)	--	407	--	ns
Q_{rr}	Reverse Recovery Charge		--	2.1	--	μC

Notes:

1、Repetitive Rating:Pulse Width Limited by Maximum Junction Temperature.

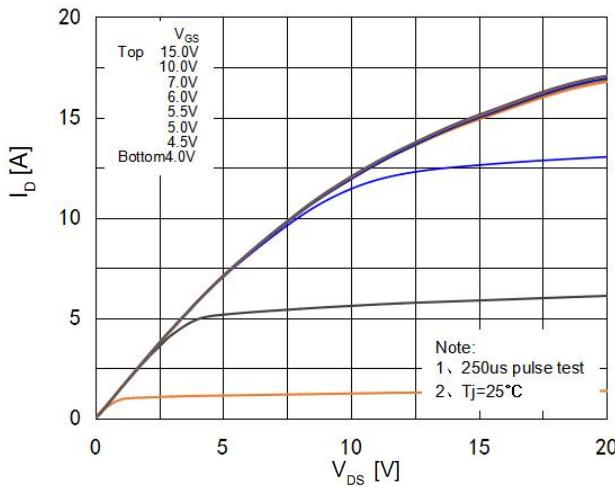
2、 $L = 8.5\text{mH}$, $I_{\text{AS}} = 9.0\text{A}$, $V_{\text{DD}} = 80\text{V}$, $R_{\text{G}} = 25 \Omega$, Starting $T_J = 25^\circ\text{C}$.

3、 $I_{\text{SD}} \leq 10.0\text{A}$, $dI/dt \leq 200\text{A}/\mu\text{s}$, $V_{\text{DD}} \leq \text{BV}_{\text{DSS}}$, Starting $T_J = 25^\circ\text{C}$.

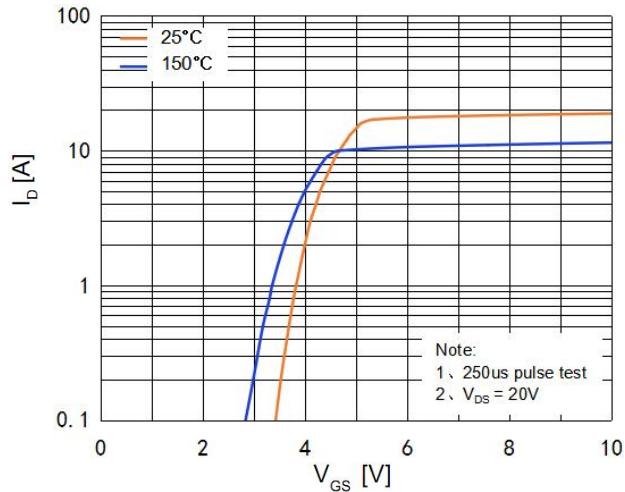
4、Pulse Test : Pulse Width $\leq 300 \mu\text{s}$, Duty Cycle $\leq 2\%$.

5、Essentially Independent of Operating Temperature.

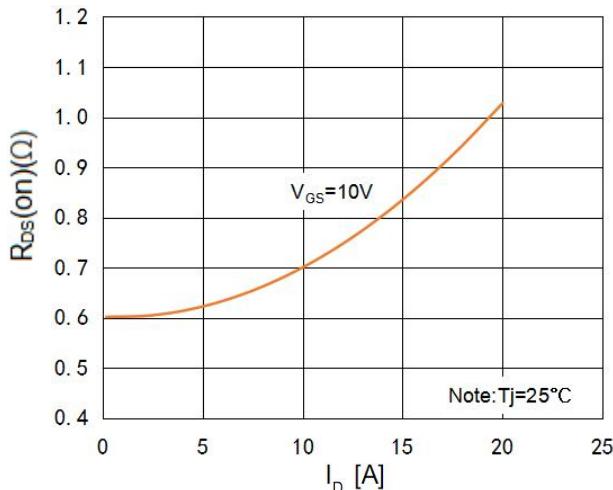
On-Region Characteristics



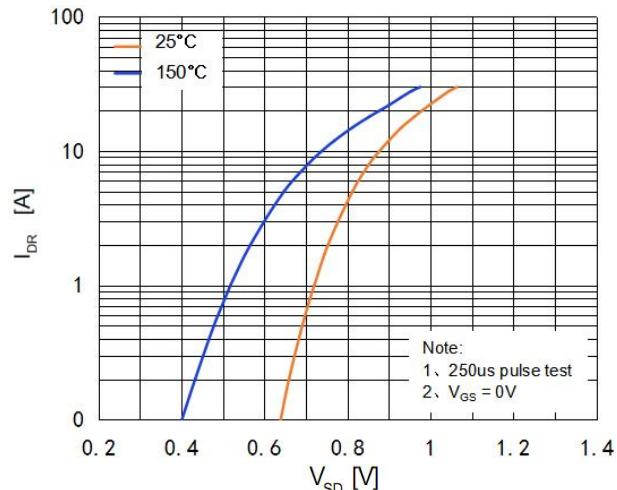
Transfer Characteristics



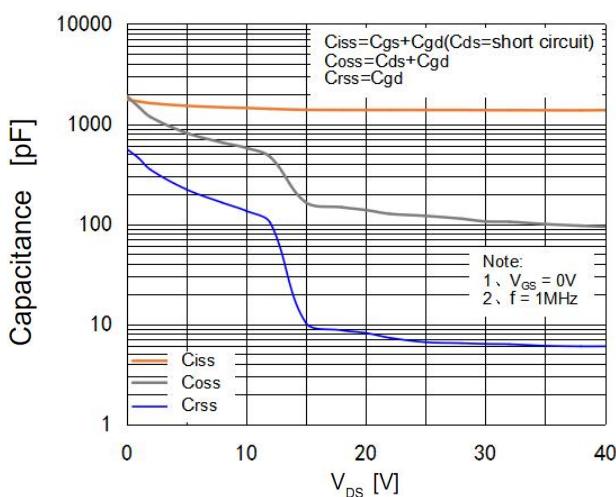
On-Resistance Variation vs. Drain Current and Gate Voltage



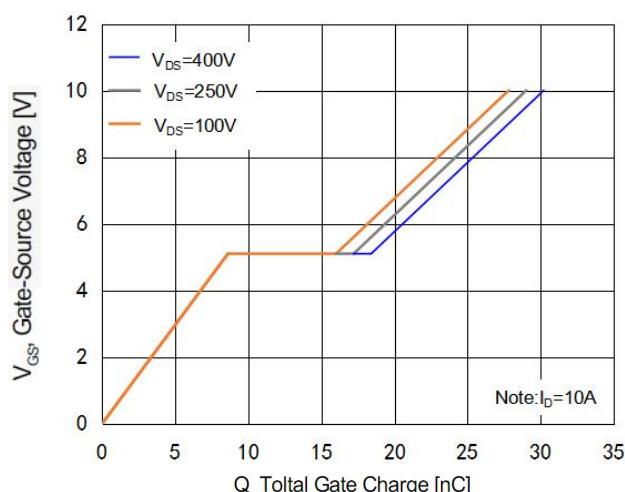
Body Diode Forward Voltage Variation vs. Source Current and Temperature



Capacitance Characteristics

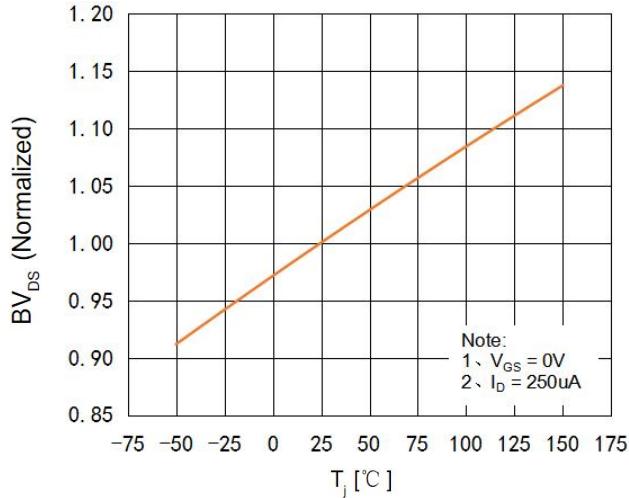
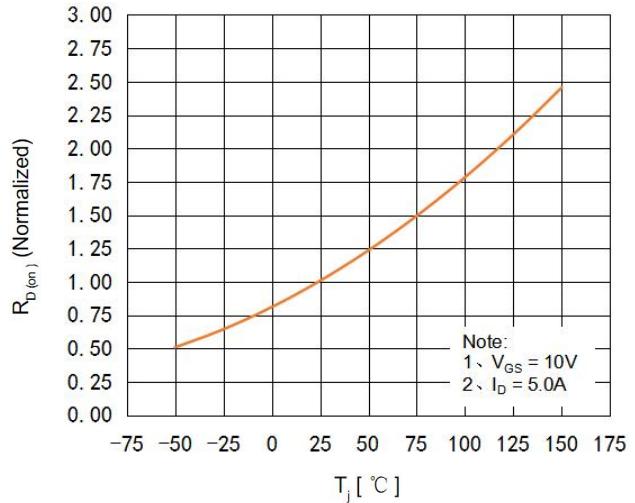
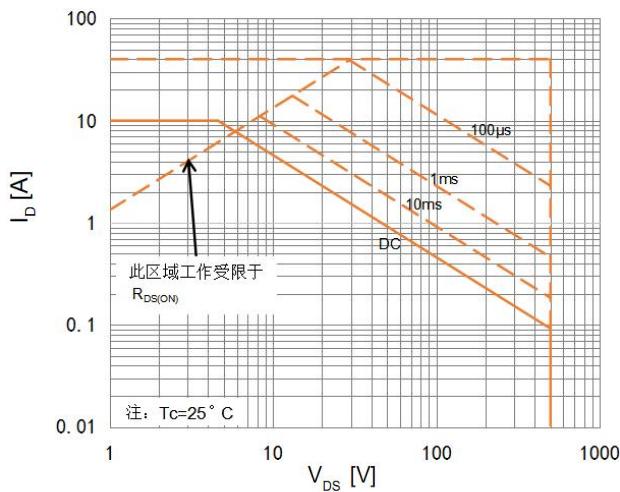
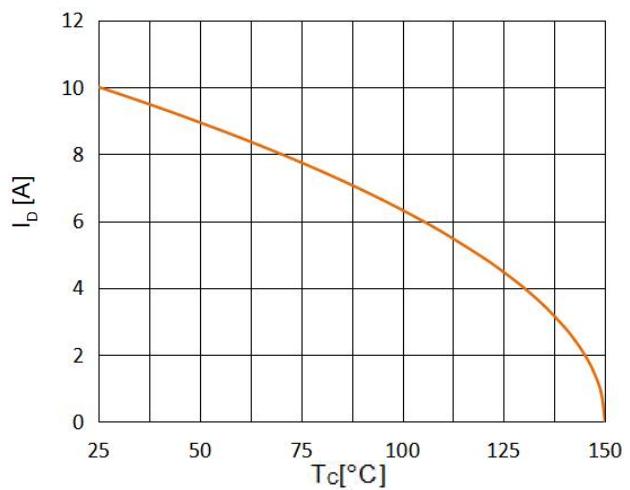


Gate Charge Characteristics



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**Breakdown Voltage Variation
vs. Temperature****On-Resistance Variation
vs. Temperature****Maximum Safe Operating Area****Maximum Drain Current
Vs. Case Temperature**

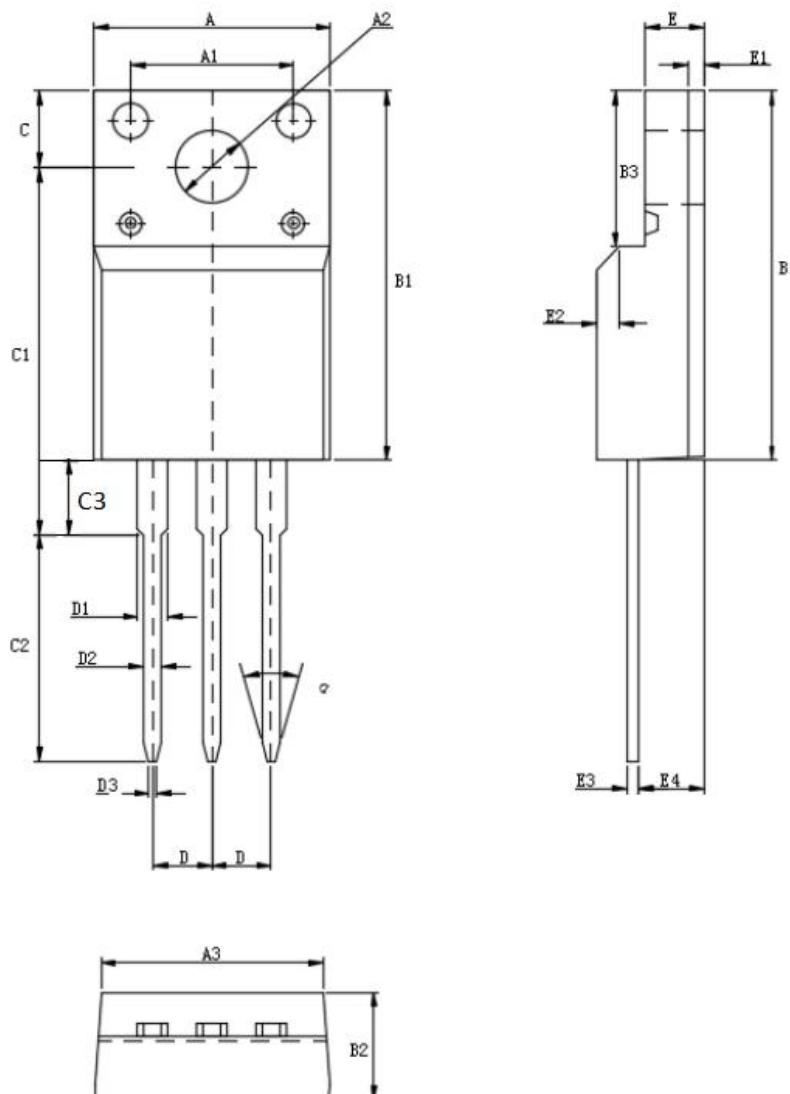
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TO-220F Package Dimensions

UNIT: mm

SYMBOL	min	nom	max	SYMBOL	min	nom	max
A	9.80		10.60	D		2.54	
A1		7.00		D1	1.15		1.47
A2	2.90		3.40	D2	0.60		0.90
A3	9.10		9.90	D3	0.20		0.50
B1	15.40		16.40	E	2.24		2.84
B2	4.35		4.95	E1		0.70	
B3	6.00		7.40	E2		1.0 × 45°	
C	3.00		3.70	E3	0.35		0.65
C1	15.00		17.00	E4	2.30		3.30
C2	8.80		10.80	α (度)		30°	
C3	2.60		3.60				





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注意事项：

- 1、在电路设计时请不要超过器件的最大额定值，否则会影响整机的可靠性。
- 2、MOSFET产品为静电敏感型器件，使用时应注意采取防静电保护措施，如佩戴防静电手环、设备接地等。
- 3、如需安装散热片，请注意控制扭力大小及散热片的平整度。
- 4、该规格书由华科公司制作，并可能不定期更改，恕不另行通知。
- 5、如有疑问，请及时联系我司销售代表。

版本履历表：

序号	版本号	修改时间	修改记录
1	V1.0	2023-6-15	首次发行